



Sandia
National
Laboratories



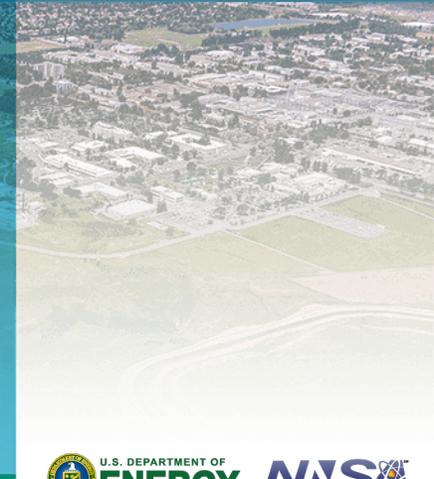
Using PDV to measure transverse and off-axis velocity

Christopher R. Johnson

Tuesday, February 7th, 2023

Org. 1647 – Solid Dynamic Experiments

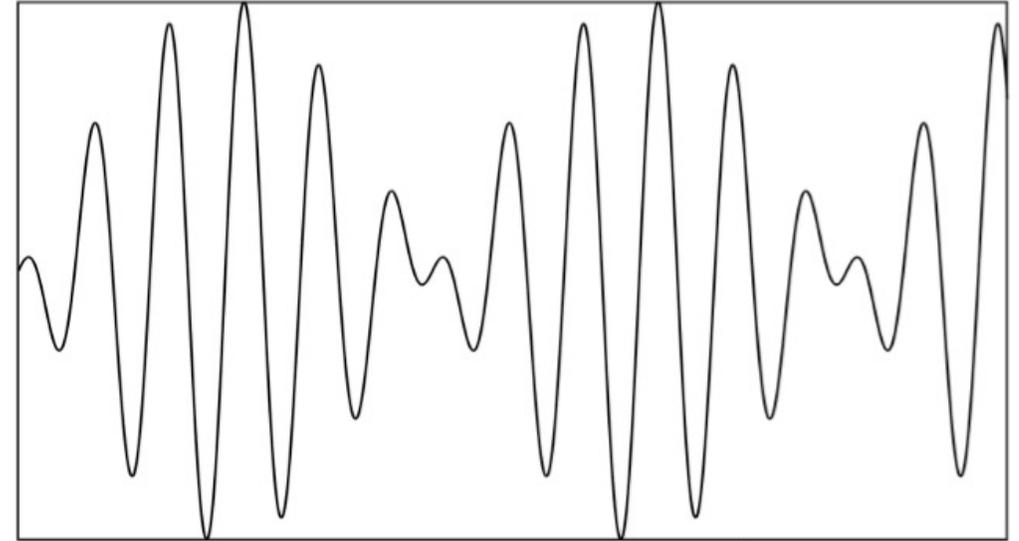
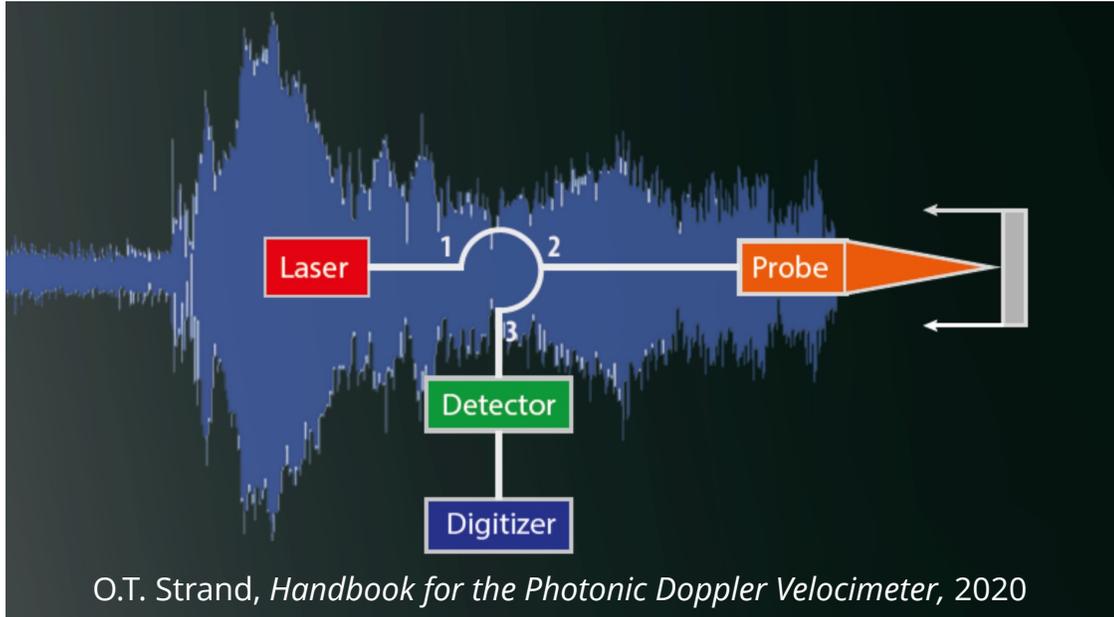
Shock Thermodynamics Applied Research Facility - (STAR)



Sandia National Laboratories is a multimission laboratory managed and operated by National Technology & Engineering Solutions of Sandia, LLC, a wholly owned subsidiary of Honeywell International Inc., for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-NA0003525.

SAND2022-9545 C

2 Introduction - PDV



- Photon Doppler Velocimetry (PDV)
 - Michelson interferometer
 - Developed by Strand et al. in 2006
 - System components leverage modern telecommunications technologies!
 - Heavily adopted by the dynamic compression community.
 - Numerous configurations have been built.

Pressure-shear plate impact experiments



General experiment:

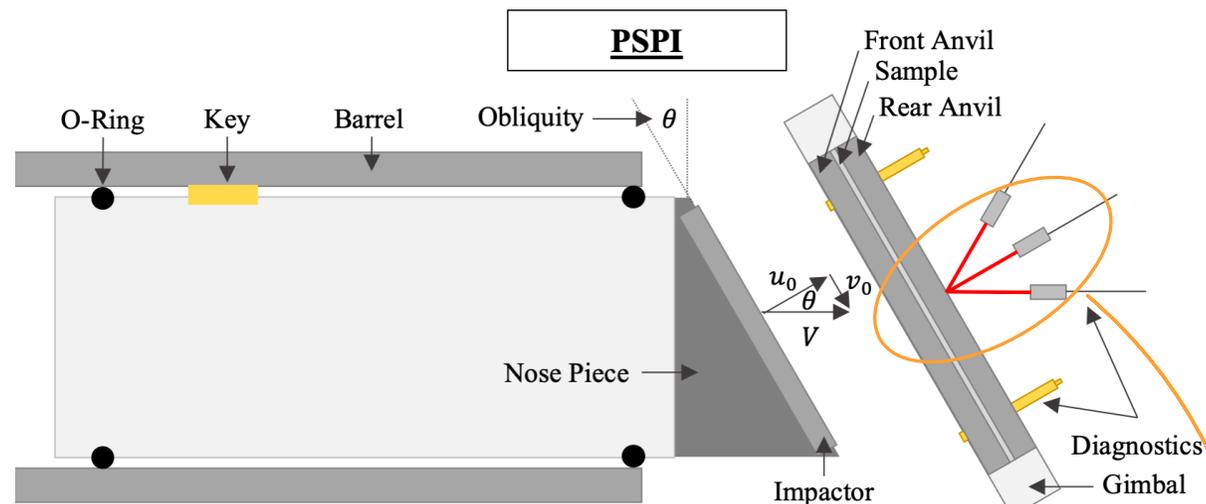
- Skewed, planar impact
- Sample sandwiched between anvils

What do you measure?

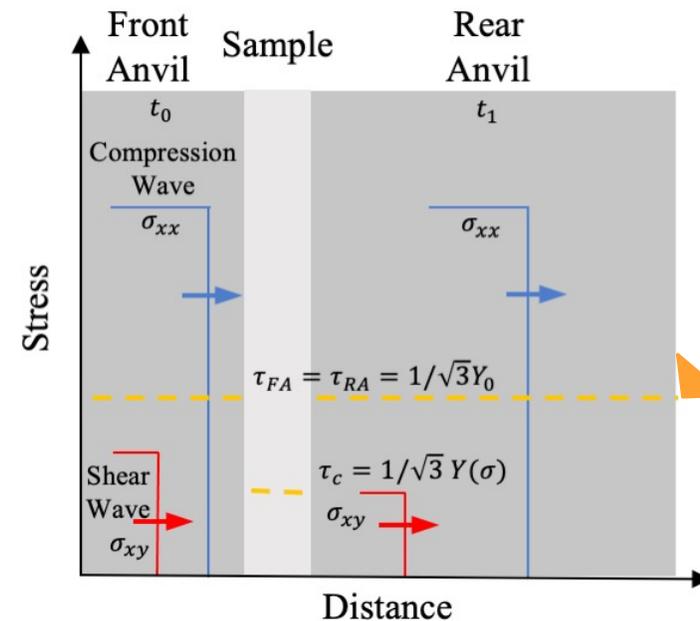
- Longitudinal & shear stress wave
- Flow strength vs. pressure

Why do we need XPDV?

- 1D waves
 - (i.e. need to measure off of the rear anvil)
- Shear wave velocities are small $\sim 0-50$ m/s
- Window of measurement is small $\sim 0.5-2$ μ s



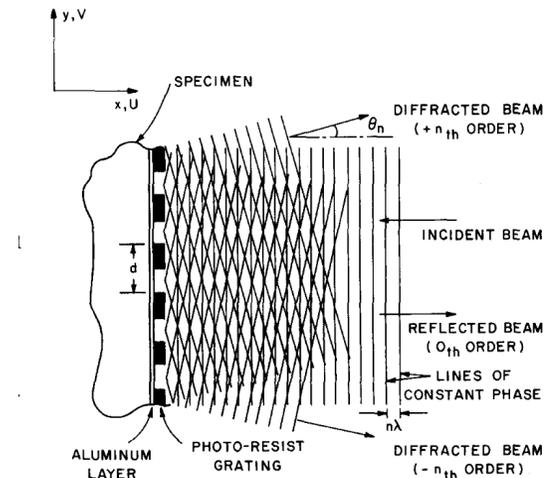
We need to measure the shear wave!



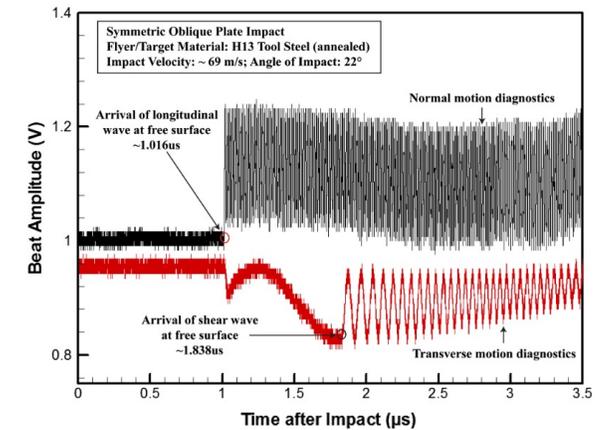
Previous methods for measuring transverse velocity



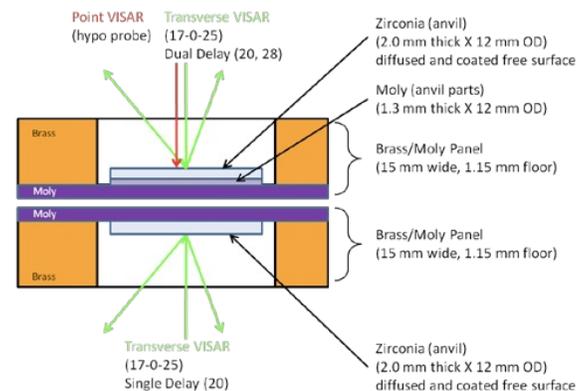
- What were the methods previously attempted?
 - NDI/TDI, VISAR, PDV
- What was found?
 - Difficult measurement
 - Need expensive diffraction gratings
 - Alignment is hard
 - Need high temporal resolution
 - Large measurement uncertainties.



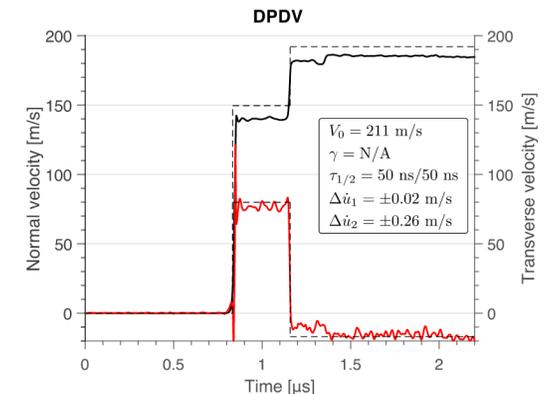
K.S. Kim, *JAP*, 1977



Zuanetti, *RSI*, 2017



Alexander, *JAP*, 2010

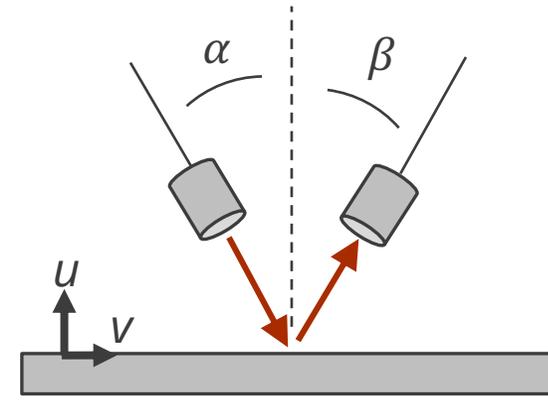


Kettenbeil, *JAP*, 2018

- A diagnostic and reflector is needed to overcome the difficulties of **light return**, **expense of diffraction gratings**, and **reduces measurement uncertainties**.

XPDV

- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement



α = Send Angle

β = Receive Angle

u = Longitudinal Velocity
(compression)

v = Transverse Velocity
(shear)

V^* = Apparent Velocity

$$V^* = \frac{u}{2} (\cos \alpha + \cos \beta) + \frac{v}{2} (\sin \alpha + \sin \beta)$$

Dolan, *Foundations of VISAR Analysis*, 2003

Solve
for u

If $\alpha, \beta = 0$
& $v = 0$

$$V^* = u$$

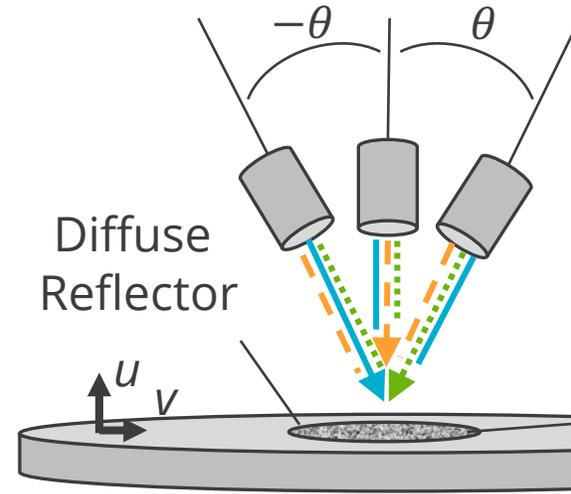
(Normal PDV operation)

Solve
for v

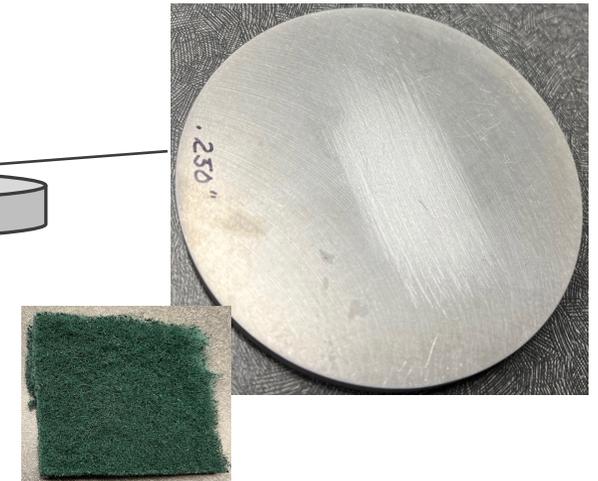
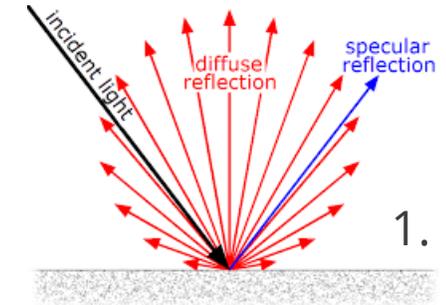
$$v = \frac{2V^* - u(\cos \alpha + \cos \beta)}{(\sin \alpha + \sin \beta)}$$

- We are solving for a small transverse velocity
- Small uncertainties are **vital** in the analysis.
- Therefore, we need high fidelity measurements of:
 - Apparent & longitudinal velocities
 - Probe angles

- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement



Diffuse Reflector

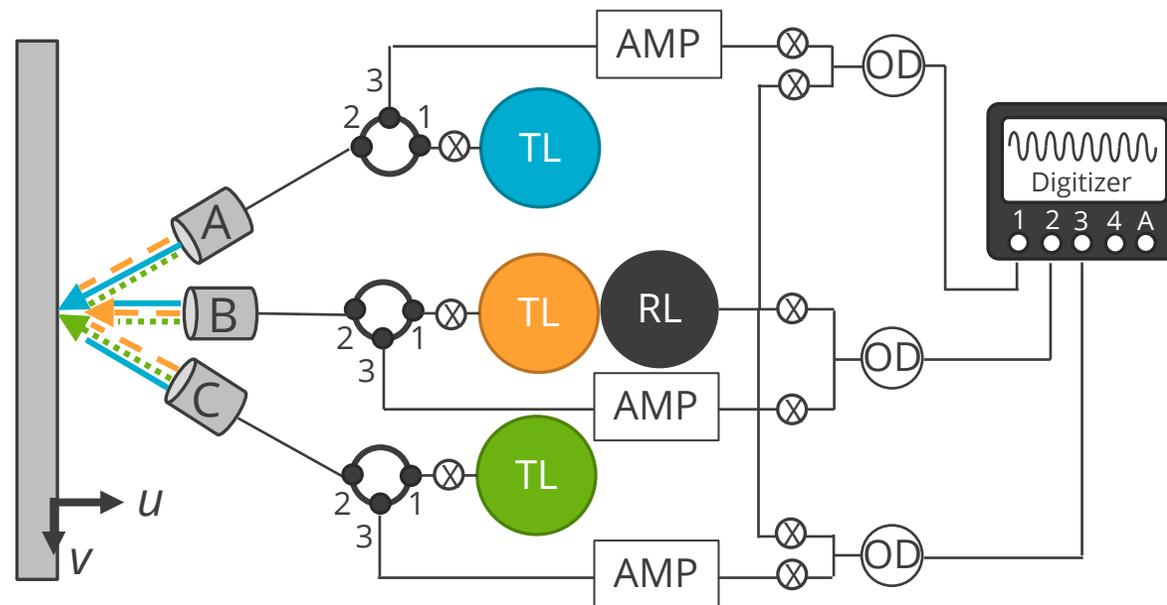


- Diffuse reflector is forgiving for optical alignment & easy to produce
- Light originates from one probe and is scattered to all three probes.

XPDV

- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement

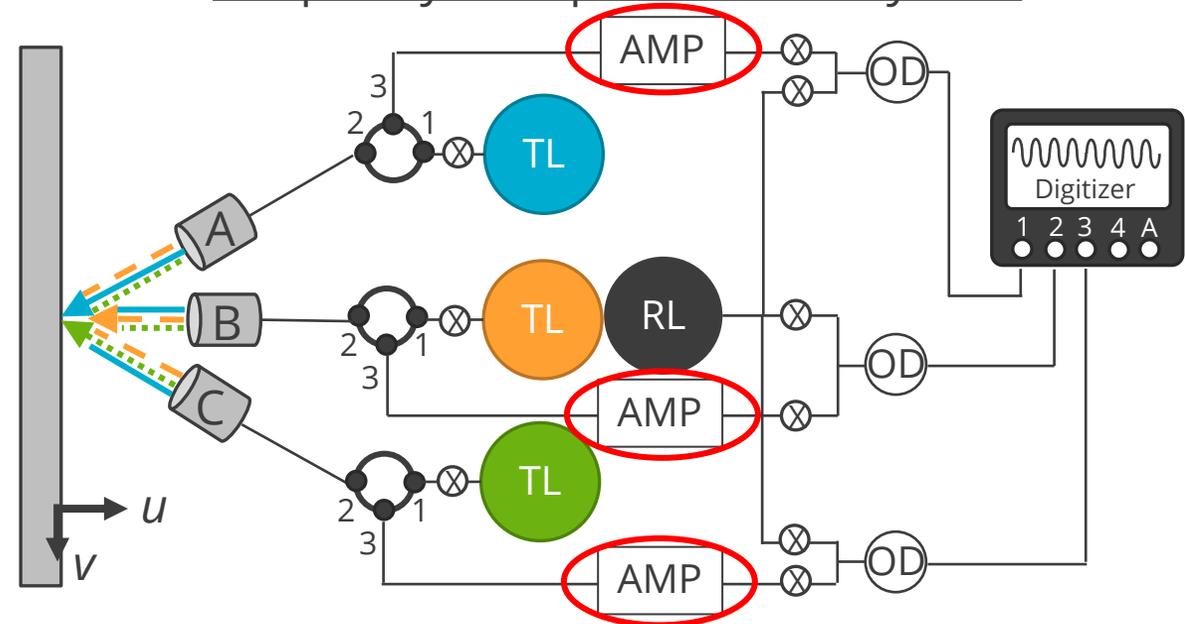
Frequency Multiplexed XPDV System



- 3 target laser wavelengths
 - (i.e. 3 multiplexed signals on each probe)
- Tune lasers for baseline frequencies of 3, 5, 8 GHz
- We can identify each optical path because of the distinct frequencies.
 - (i.e. we know which probe sent the light!)

- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement

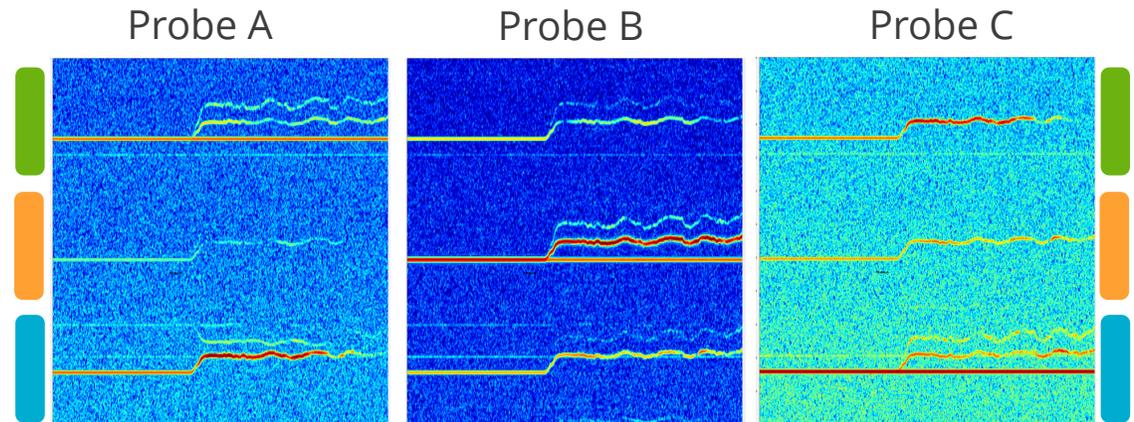
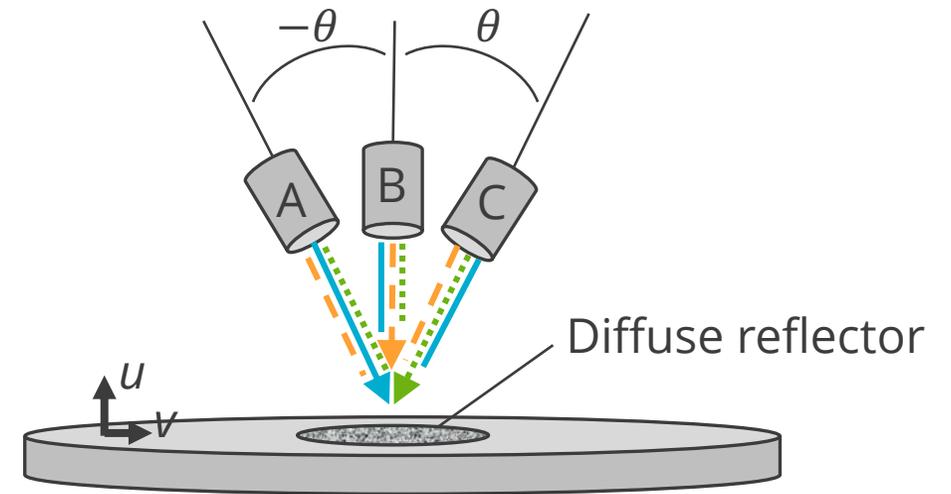
Frequency Multiplexed XPDV System



- Low light return levels
 - 40 mW laser \rightarrow -60 to -40 dBm of return
- Back end amplifiers amplify return light.

XPDV

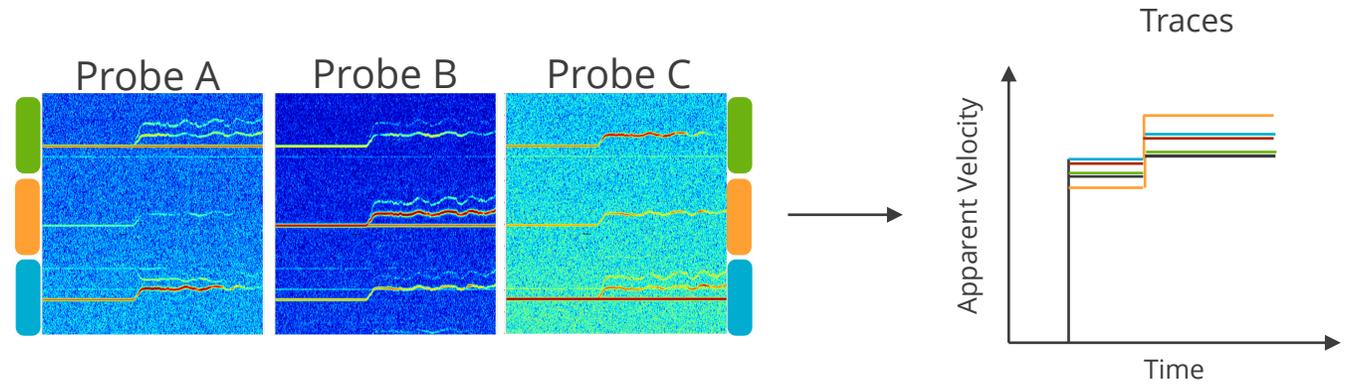
- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement



- Many measurements made via frequency multiplexing.
- Each measurement has a characterized optical path.

XPDV

- Theory
- Probe setup
 - 3 – collimating probes
 - Diffuse reflector
- XPDV overview
 - A modified frequency multiplexed heterodyne system
- Light Return
 - Back end amplifiers
- Frequency multiplexing
- Measurement



Weighted Average

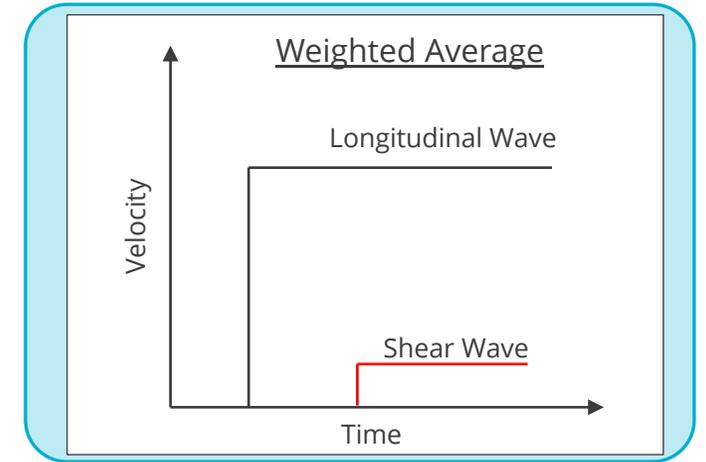
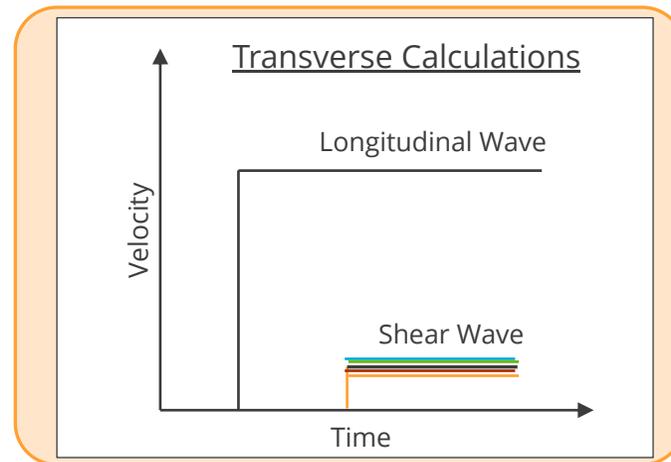
$$v_{i,j} = \frac{2V_i^* - u_j(\cos\alpha_i + \cos\beta_i)}{\sin\alpha_i + \sin\beta_i}$$

$$\partial v_{i,j} = \sqrt{\left[\frac{\partial v_{i,j}}{\partial V_i^*} \partial V_i^*\right]^2 + \left[\frac{\partial v_{i,j}}{\partial V_N} \partial V_N\right]^2 + \left[\frac{\partial v_{i,j}}{\partial \alpha_i} \partial \alpha_i\right]^2 + \left[\frac{\partial v_{i,j}}{\partial \beta_i} \partial \beta_i\right]^2}$$

$$\bar{v} = \frac{\sum_{i=1}^N \sum_{j=1}^M w_{i,j} v_{i,j}}{\sum_{i=1}^N \sum_{j=1}^M w_{i,j}}$$

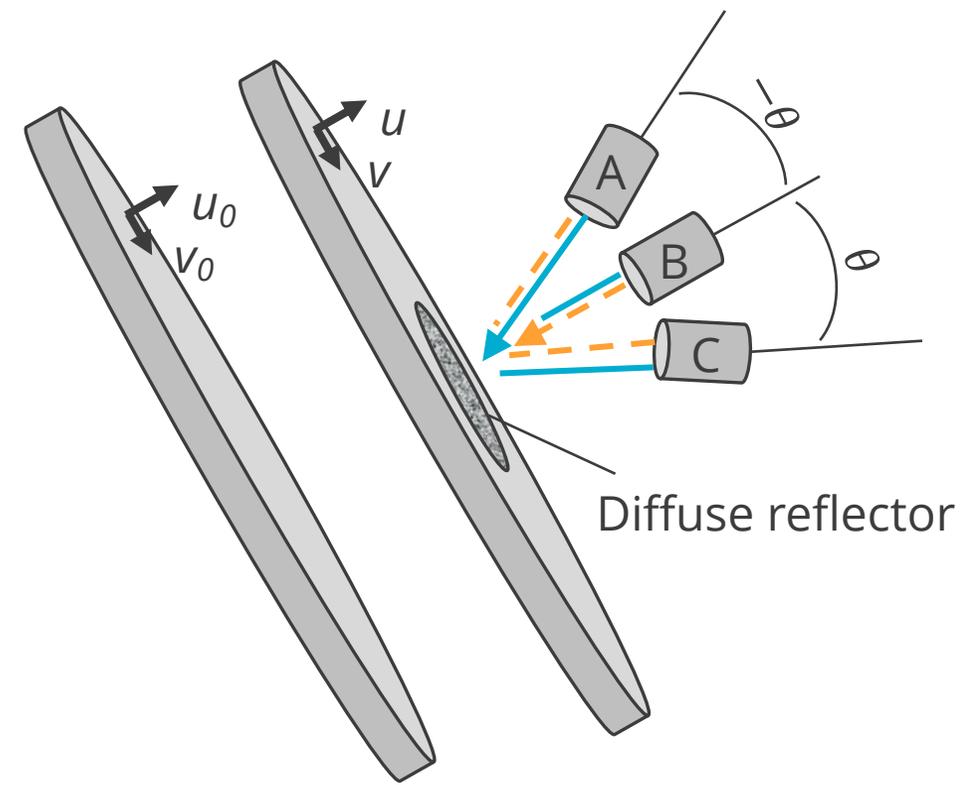
$$w_{i,j} = \frac{1}{(\partial v_{i,j})^2}$$

$$\partial \bar{v} = \left(\sum_{i=1}^N \sum_{j=1}^M w_{i,j}\right)^{-1/2}$$

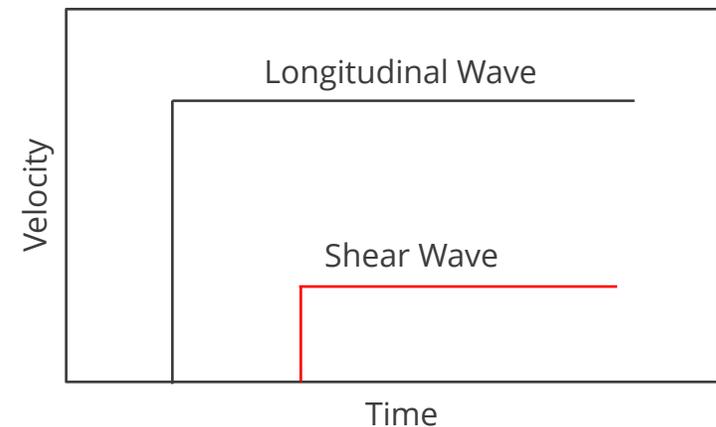


Validation Experiment

- A validation experiment was designed for the XPDV system.
- Impact between 2 – 6061-T6 aluminum disks.
 - 75 m/s impact
 - Skew angle = 15°
- XPDV was fielded
 - Only **two** laser sources in this example...



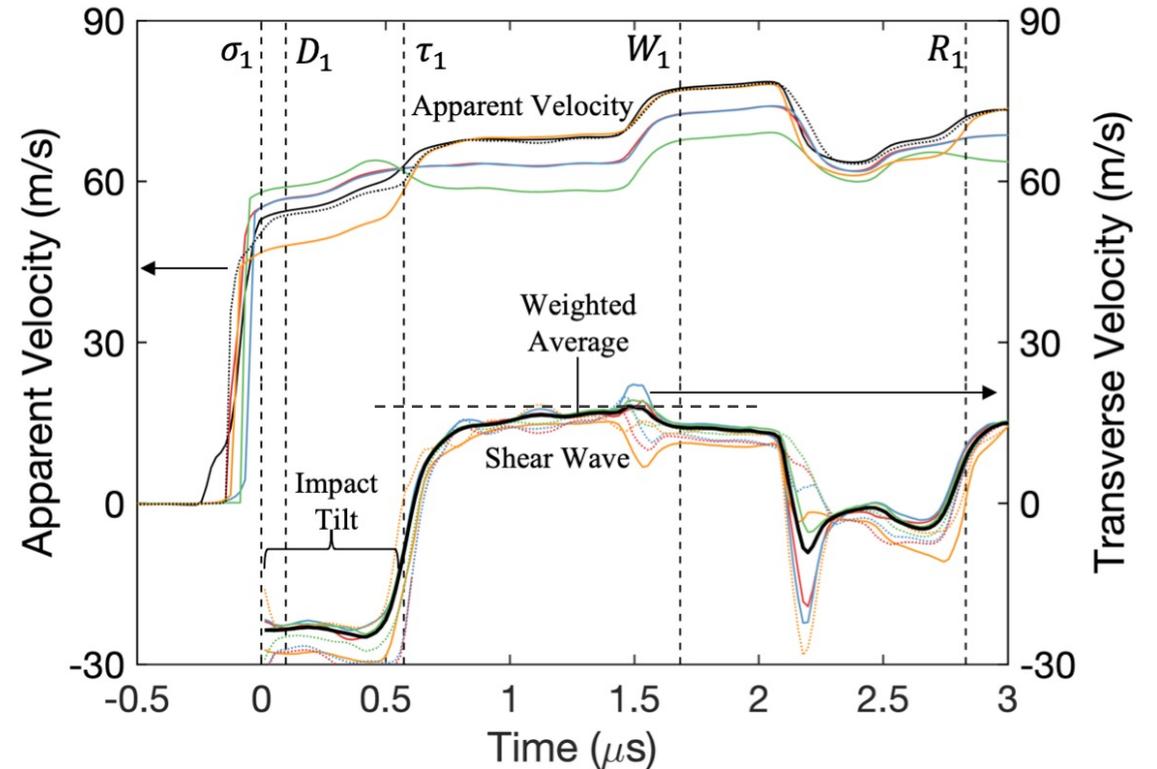
Expected Wave Profile



Validation Experiments: Results



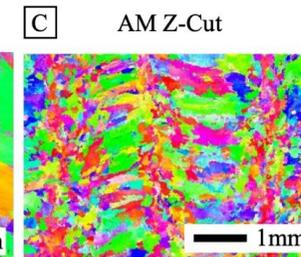
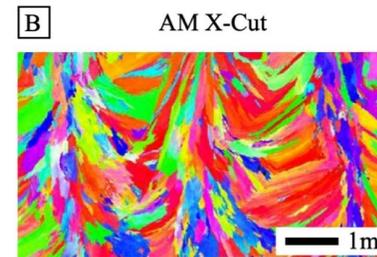
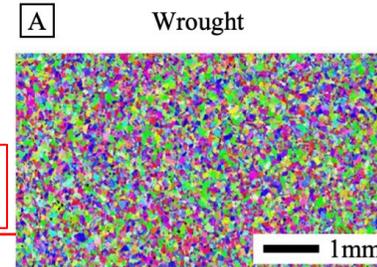
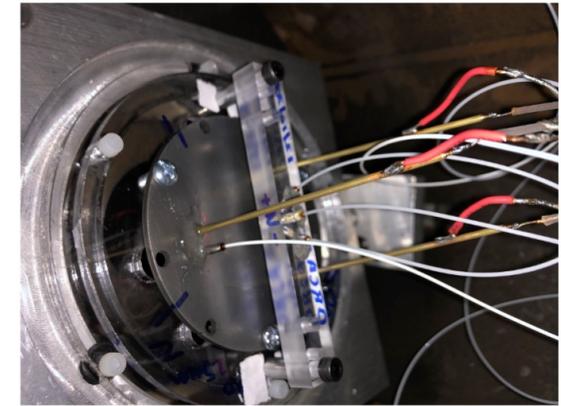
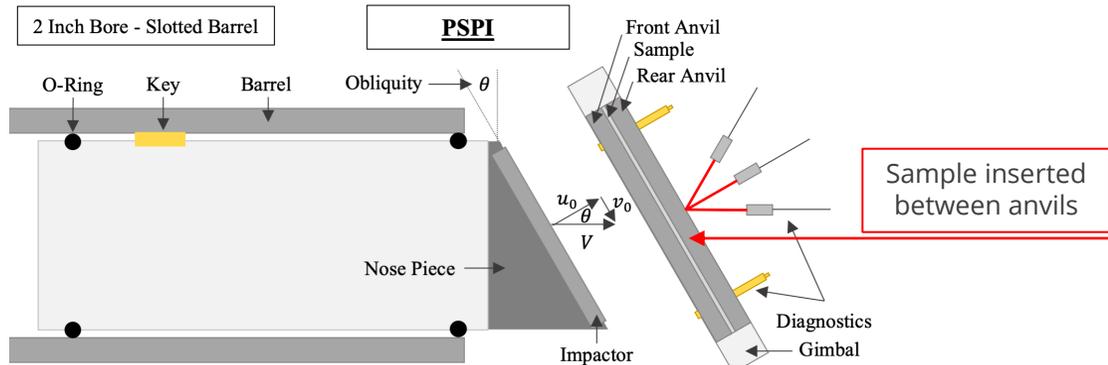
- Waveforms:
 - 6 apparent velocities
 - Timing agrees well with theory
 - Tilt effects
 - Structure changes when shear wave arrives
- Analysis:
 - Yields 8 transverse velocity measurements.
 - Weighted average used to determine statistical best.
- How does this compare with theory?
 - Impact velocity was 75 m/s
 - i.e. $u_0=72$ m/s, $v_0=19$ m/s
 - v within shear window was 18 ± 3 m/s.
 - Agrees well with theoretical of 19 m/s!



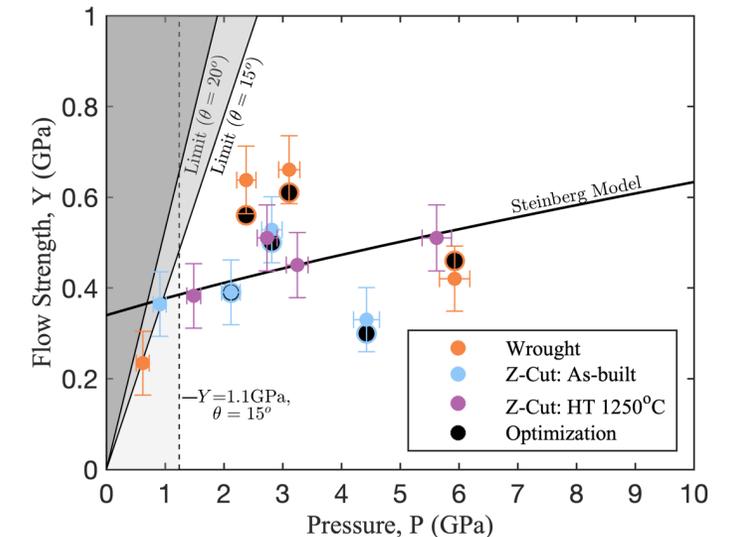
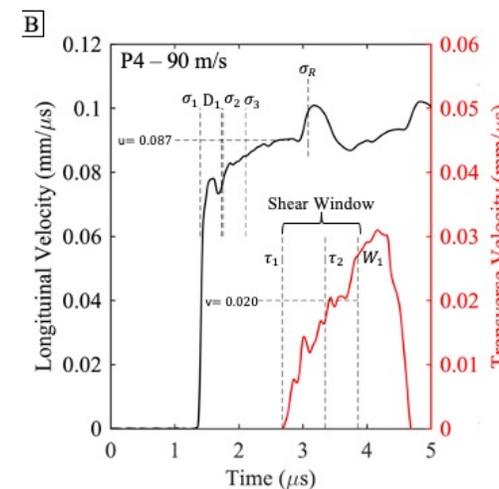
	Theory (m/s)	Exp. (m/s)
u	72	70
v	19	18 ± 3

$$v = \frac{2V^* - u(\cos \alpha + \cos \beta)}{(\sin \alpha + \sin \beta)}$$

Use of XPDV in an Experimental Series



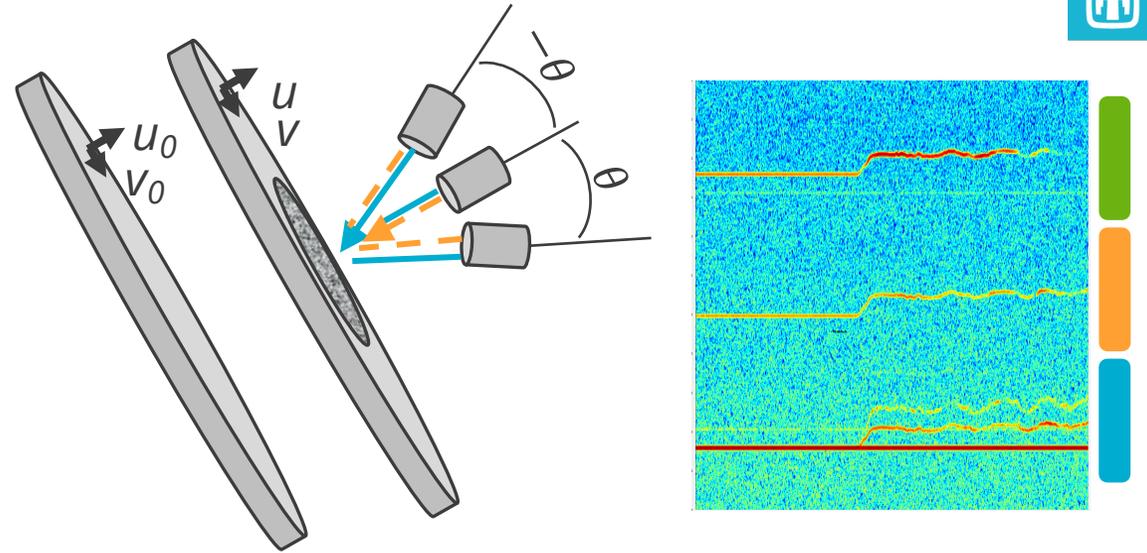
- Experiments were performed to compare dynamic behavior of SS304L.
 - Wrought, as-built AM, & heat treated AM
- Does fabrication process influence strength?
- Loading conditions: $P = 0-6$ GPa
- Results are compared between varieties and to existing strength model.
- XPDV is highly effective for these measurements.



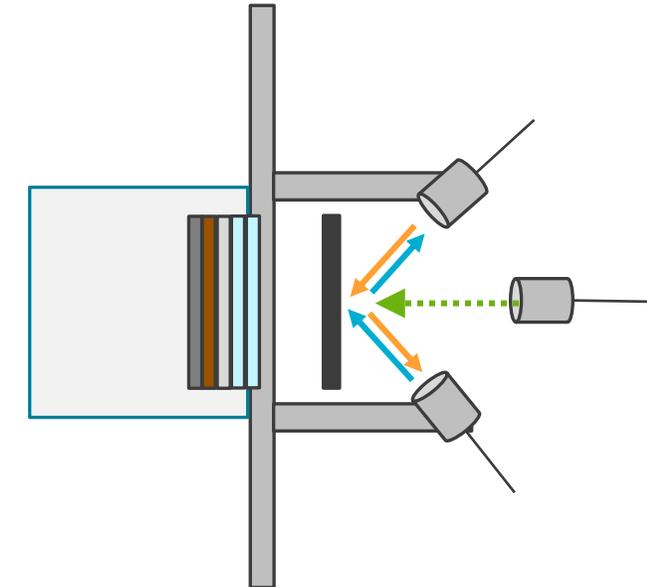
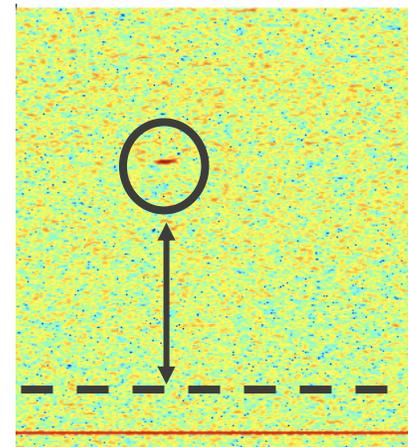
Summary

- XPDV was developed for the measurement of off axis velocities.
- The system overcomes many difficulties:
 - Light return issues
 - Reflectors
 - Measurement uncertainties
- Highly functional diagnostic for pressure shear plate impact experiments
- Other applications: Hyper velocity launches

Pressure Shear Plate Impact Experiments



Hypervelocity Launches



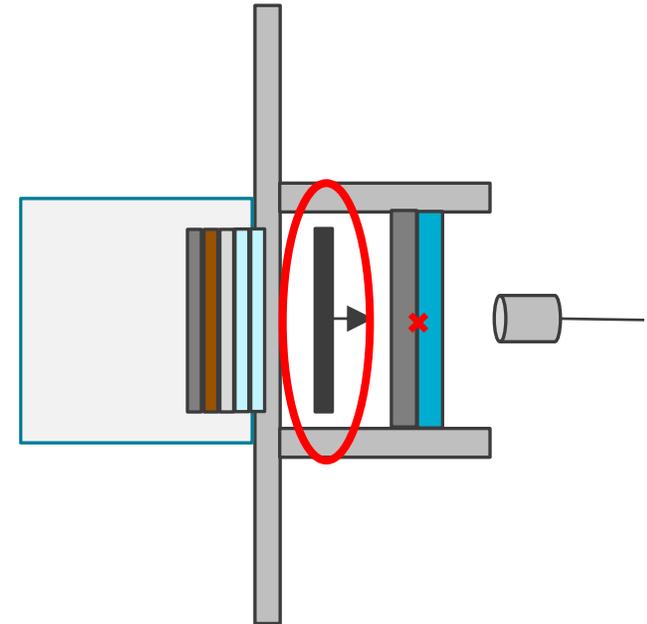
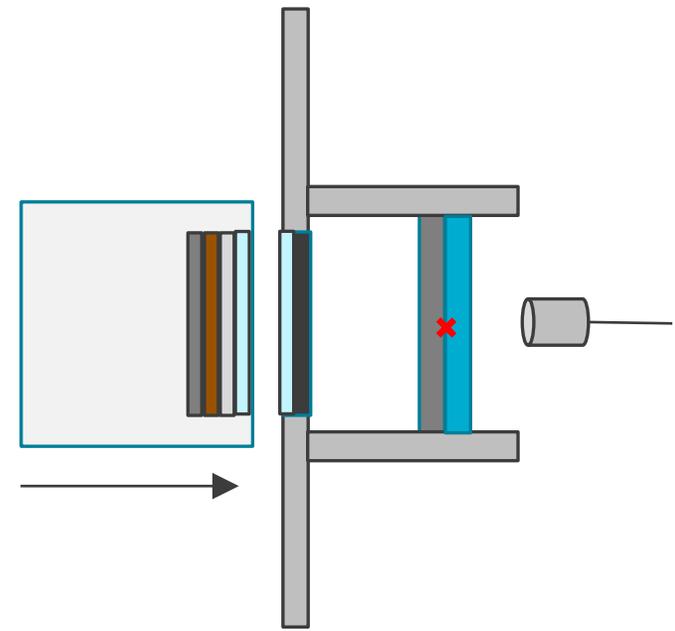


Extras

Other applications - HVL

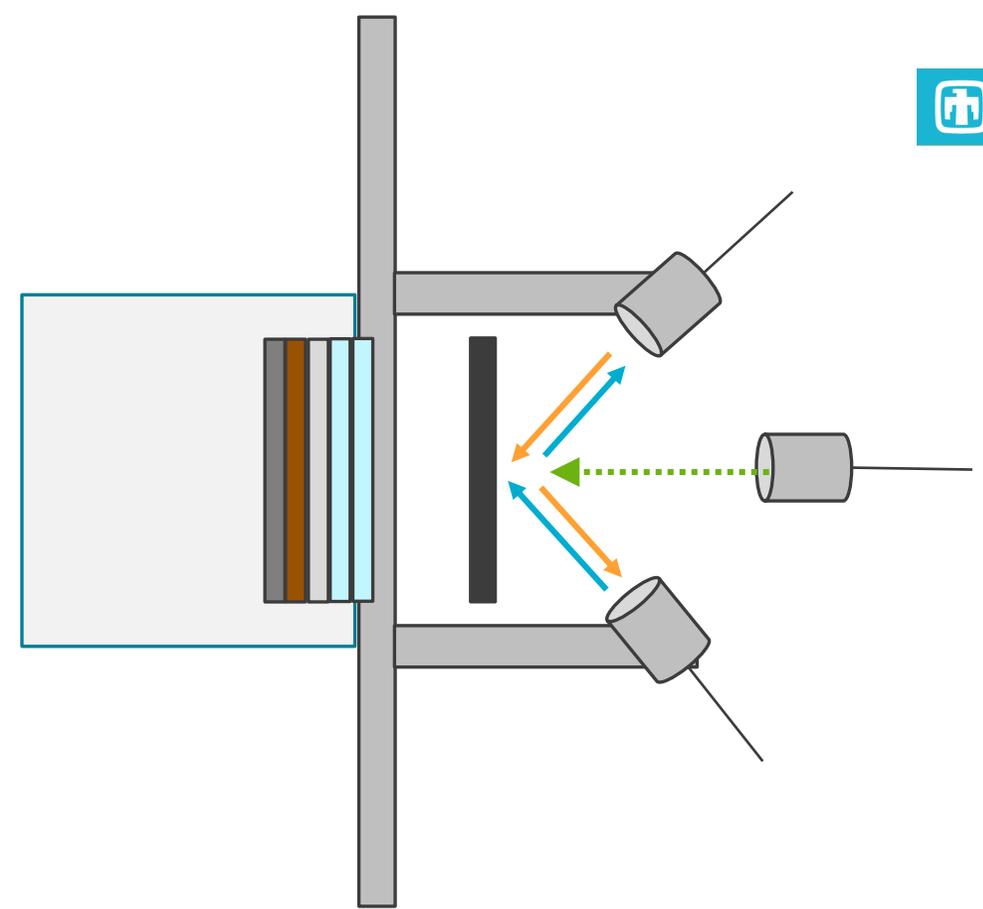
- STAR developed GDI techniques for hyper velocity launches in the 1980's.
- A plate is launched at velocities ranging between 7-13 km/s.
- It is difficult to measure the flyer velocity due to geometric limitations.

Can XPDV be used to measure the flyer velocity?



Validation Experiment

- Hyper velocity launch using GDI into Ti flyer.
- XPDV techniques are compared to a normal PDV probe.
 - Two off axis probes are placed symmetric about the flyer. (55 degree skew angle)
 - Cosine correction for the velocity
 - A normal probe to measure 'true velocity'.
- Results are compared to assess validity of results.



$$V^* = \frac{u}{2} (\cos \alpha + \cos \beta) + \frac{v}{2} (\sin \alpha + \sin \beta)$$



$$u = \frac{2V^*}{(\cos \alpha + \cos \beta)}$$

Results

- GDI impact of 5.122 km/s into flyer.
- Normal PDV: 7.85 km/s
- Off-axis PDV: ($\alpha, \beta = \pm 55^\circ$)
 - XPDV 3:
 - Apparent: 4.45 km/s
 - Corrected: 7.75 km/s
 - XPDV 4:
 - Apparent: 4.46 km/s
 - Corrected: 7.78 km/s
- Measurement accuracy within 2% of true velocity

